

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{ extsf{ heta}JA}$	76	95	°C/W			
Maximum Junction-to-Ambient A	Steady State	ιχ _θ ja	118	150	°C/W			
Maximum Junction-to-Lead ^C	Steady State	$R_{ extsf{ heta}JL}$	54	68	£\M			

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$	20			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 20V, V_{GS} = 0V$			1	μA
	Zero Gale Voltage Drain Gurrent	T _J = 55℃			5	μΛ
I _{GSS}	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 10V$			±10	υΑ
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = 250 \mu A$	0.5	0.7	1	V
I _{D(ON)}	On state drain current	$V_{GS} = 4.5V, V_{DS} = 5V$	25			Α
R _{ds(on)}		$V_{GS} = 4.5V, I_{D} = 5.0A$	18	23	28	mΩ
		T _J =125℃	26	33	40	11152
	Static Drain-Source On-Resistance	$V_{GS} = 4.0V, I_{D} = 4.5A$	19	24	30	mΩ
		$V_{GS} = 3.1V, I_D = 4.5A$	20	27	34	mΩ
		$V_{GS} = 2.5V, I_{D} = 4.0A$	21	30	39	mΩ
g _{FS}	Forward Transconductance	$V_{DS} = 5V, I_{D} = 5.0A$		18		S
V _{SD}	Diode Forward Voltage	$I_{\rm S} = 1$ A, $V_{\rm GS} = 0$ V		0.65	1	V
I _S	Maximum Body-Diode Continuous Curr			1.3	Α	
DYNAMIC	C PARAMETERS			-	-	
C _{iss}	Input Capacitance			180	225	pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =10V, f=1MHz		95		pF
C _{rss}	Reverse Transfer Capacitance			18		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		2.7	4	kΩ
SWITCHI	NG PARAMETERS	· · · · · · · · · · · · · · · · · · ·			-	
Q _g	Total Gate Charge			5.6	7.5	nC
Q _{gs}	Gate Source Charge	V_{GS} = 4.5V, V_{DS} = 10V, I_{D} = 5A		0.85		nC
Q _{gd}	Gate Drain Charge	7		1.7		nC
t _{D(on)}	Turn-On DelayTime			172		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =10V, R_{L} =2.0 Ω ,		368		ns
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		2.94		ບຮ
t _f	Turn-Off Fall Time	7		2.5		υs
t _{rr}	Body Diode Reverse Recovery Time	I _F =5A, dl/dt=100A/μs		32	43	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I_F =5A, dI/dt=100A/ μ s		3.2		nC

Electrical Characteristics (T_J=25°C unless otherwise noted)

A: The value of R_{6JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. in any given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

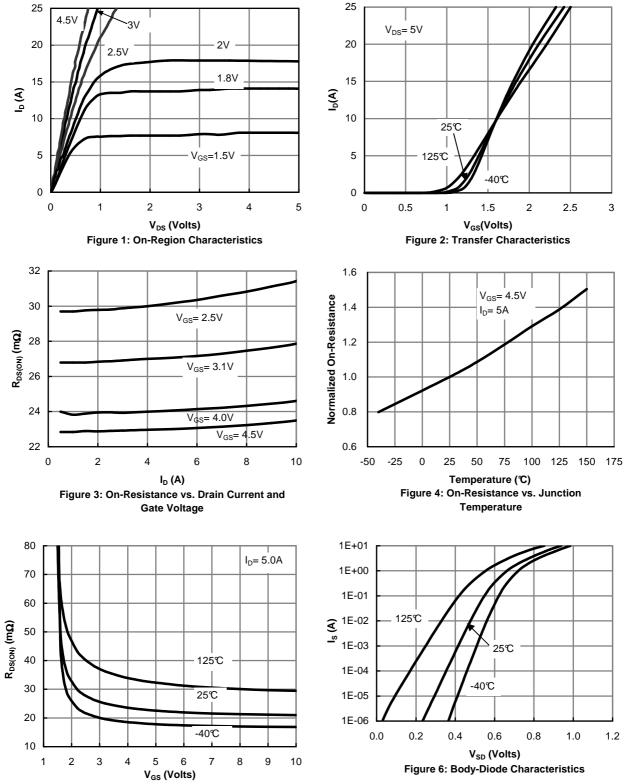
C. The R $_{\text{\tiny BJA}}$ is the sum of the thermal impedence from junction to lead R $_{\text{\tiny BJL}}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using < 300 μs pulses, duty cycle 0.5% max.

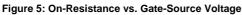
E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

Rev2: Nov. 2010

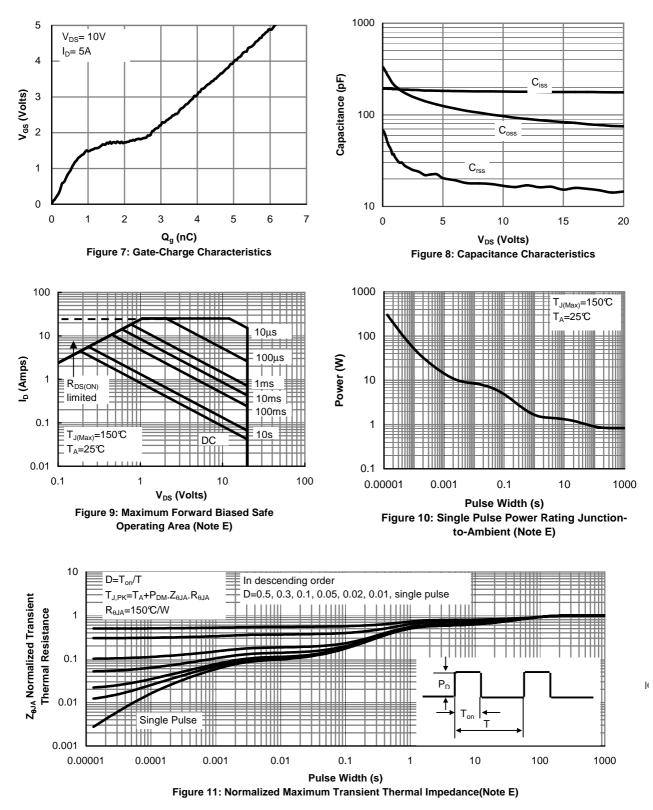
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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

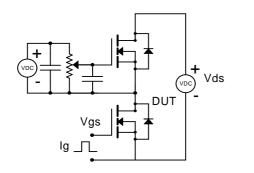


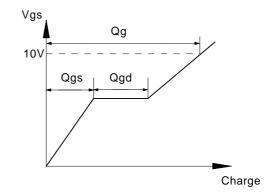
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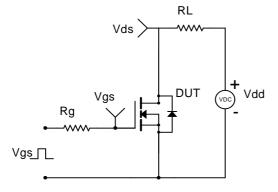
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

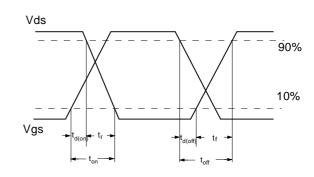
Gate Charge Test Circuit & Waveform



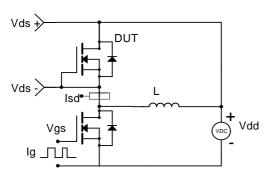


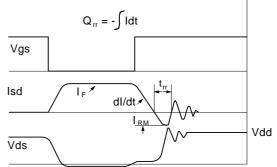
Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms





单击下面可查看定价,库存,交付和生命周期等信息

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